Notice of References Cited Application/Control No. 10/784,782 Examiner Stephen G. Sherman Applicant(s)/Patent Under Reexamination HAN ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|--------------------|----------------|
| * | Α | US-6,232,935 | 05-2001 | Fukushima et al | 345/67 |
| * | В | US-2003/0071577 | 04-2003 | Du et al. | 315/169.3 |
| * | С | US-6,252,568 | 06-2001 | Iseki et al. | 345/60 |
| * | D | US-7,030,839 | 04-2006 | Higashino et al. | 345/60 |
| * | E | US-2003/0122742 | 07-2003 | Akiba, Yutaka | 345/63 |
| * | F | US-6,876,340 | 04-2005 | Kobayashi, Kenichi | 345/60 |
| * | G | US-2003/0095084 | 05-2003 | Mizobata, Eishi | 345/60 |
| | Н | US- | | | |
| | ١ | US- | | | |
| | J | US- | | | |
| | К | US- | | | |
| | L | US- | | | |
| | М | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | 0 | | | | | |
| | Р | | | | | |
| | σ | | | | | |
| | R | | | | | |
| | S | | | | | |
| | Т | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) | |
|---|---|---|--|
| | υ | | |
| | V | | |
| | w | | |
| | × | | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.